



AdvancedTCA<sup>®</sup> Extensions for  
Instrumentation and Test

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**Press Release – For Immediate Release**

## **AXIe 3.1 Sessions at the International Test Conference (ITC)**

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**Niwot, Colorado – October 21, 2010 –** During ITC 2010, October 31-November 5 in Austin, Texas the emerging AXIe 3.1 standard for semiconductor test will be presented during the lively ITC poster session and beer blast reception on Tuesday, Nov. 2<sup>nd</sup>, 6 pm – 8 pm. Look for “poster” sessions, PO 1 & PO 2 in the program: *AXIe<sup>®</sup>: Open-Architecture Test System Standard* by A. Czamara, [Test Evolution](#) and *AXIe<sup>®</sup> 2.0 and MVP-C: Open ATE Software Standards* by K. Spargo, Test Evolution. The Chair of the Poster session is *W. Eklow*, Cisco Systems.

The first session (PO 1) will focus on AXIe 3.1 hardware, including features and benefits of the open standard for ATE instrumentation. AXIe 3.1 provides the basis for full-scale ATE features while lowering the cost of test and ownership.

The second session (PO 2) will focus on features proposed for the future AXIe software standard, which will support open system configuration. Also, there will be a discussion of an open instrumentation programming methodology that works with the recently released AXIe 3.1 standard and provides software interchangeability of instrumentation for the ATE industry, as well as multisite extension of test applications.

For more information about the AXIe standard for general purpose and semiconductor test, go to [www.axiestandard.org](http://www.axiestandard.org).

For more information about Test Evolution, go to [www.testevolution.com](http://www.testevolution.com).

## **About the AXIe Consortium**

The founding members of the [AXIe Consortium](#) are Aeroflex Corporation, Agilent Technologies Inc., and Test Evolution Corporation. AXIe is a standard based on AdvancedTCA (ATCA) with extensions for instrumentation and test. The mission of the AXIe Consortium is to provide an open standard that creates a robust ecosystem of components, products and systems for general purpose instrumentation and semiconductor test. AXIe leverages existing standards from PXI, LXI and IVI. AXIe promises high scalability and performance that will address a range of platforms from bench top measurements to rack and stack modular to ATE systems.

Since its formation, the AXIe Consortium has grown to eight members from the instrumentation and industrial computer industries (<http://www.axiestandard.org/members.html>). First AXIe products have been released by two consortium members and are viewable on the website at <http://axiestandard.org/products.html>.

[AXIe Consortium membership](#) is open to all vendors who agree with the stated goals and intend to provide solutions to the marketplace.

## **Trademarks**

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AXIe is a trademark of the AXIe Consortium, Inc. pending approval.

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